AMD Xilinx - XC3S50-4PQ208I Datasheet

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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	192
Number of Logic Elements/Cells	1728
Total RAM Bits	73728
Number of I/O	124
Number of Gates	50000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	208-BFQFP
Supplier Device Package	208-PQFP (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s50-4pq208i

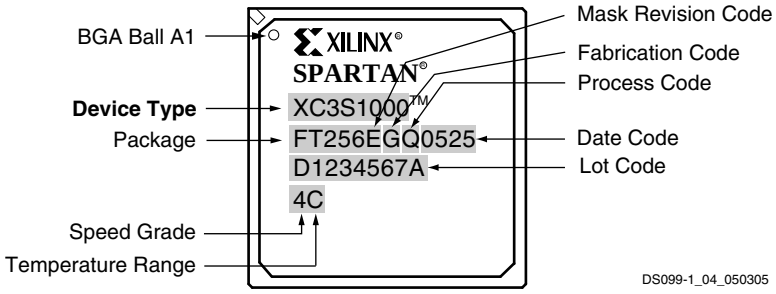

Figure 3: **Spartan-3 FPGA BGA Package Marking Example for Part Number XC3S1000-4FT256C**

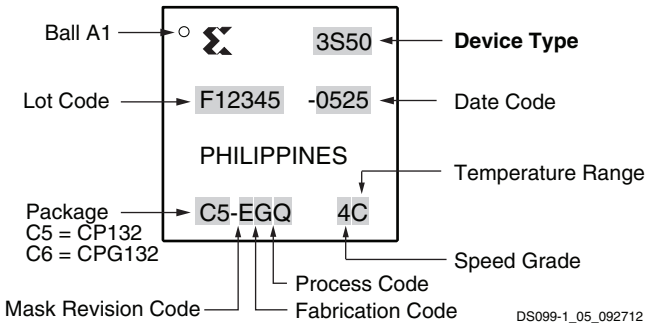

Figure 4: **Spartan-3 FPGA CP132 and CPG132 Package Marking Example for XC3S50-4CP132C**

Ordering Information

Spartan-3 FPGAs are available in both standard (Figure 5) and Pb-free (Figure 6) packaging options for all device/package combinations. The Pb-free packages include a special 'G' character in the ordering code.

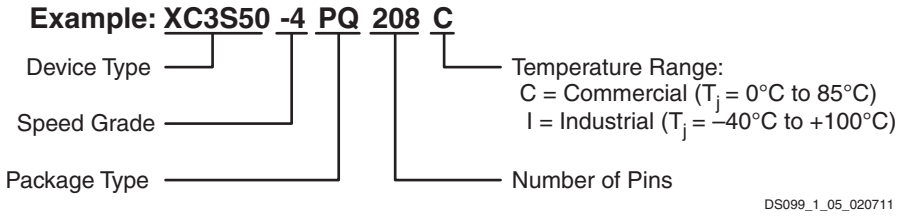

Figure 5: **Standard Packaging**

For additional information on Pb-free packaging, see XAPP427: *Implementation and Solder Reflow Guidelines for Pb-Free Packages*.

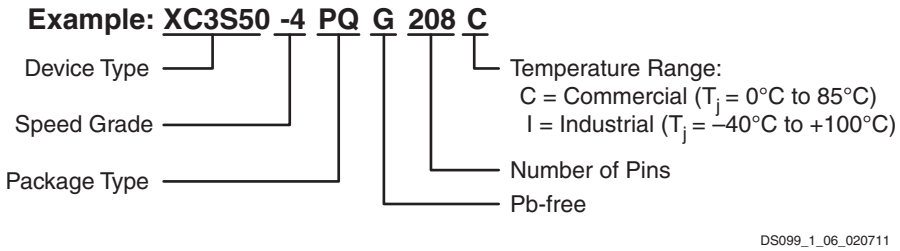

Figure 6: **Pb-Free Packaging**

Table 28: Absolute Maximum Ratings (Cont'd)

Symbol	Description	Conditions	Min	Max	Units
I_{IK}	Input clamp current per I/O pin	0.5 V < V_{IN} < (V_{CCO} + 0.5 V)		–100	mA
V_{ESD}	Electrostatic Discharge Voltage pins relative to GND	Human body model		–2000	V
		Charged device model		–500	V
		Machine model		–200	V
T_J	Junction temperature			125	°C
T_{SOL}	Soldering temperature(4)			220	°C
T_{STG}	Storage temperature		65	150	°C

Notes:

1. Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions beyond those listed under the Recommended Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time adversely affects device reliability.
2. All User I/O and Dual-Purpose pins (DIN/D0, D1 D7, CS_B , RDWR_B, BUSY/DOUT, and INIT_B) draw power from the V_{CCO} power rail of the associated bank. Keeping VIN within 500 mV of the associated V_{CCO} rails or ground rail ensures that the internal diode junctions that exist between each of these pins and the V_{CCO} and GND rails do not turn on. Table 32 specifies the V_{CCO} range used to determine the max limit. Input voltages outside the 0.5V to V_{CCO}+0.5V voltage range are permissible provided that the I_{IK} input clamp diode rating is met and no more than 100 pins exceed the range simultaneously. Prolonged exposure to such current may compromise device reliability. A sustained current of 10 mA will not compromise device reliability. See XAPP459, Eliminating I/O Coupling Effects when Interfacing Large-Swing Single-Ended Signals to User I/O Pins on Spartan-3 Generation FPGAs for more details. The VIN limits apply to both the DC and AC components of signals. Simple application solutions are available that show how to handle overshoot/undershoot as well as achieve PCI compliance. Refer to the following application notes: XAPP457, Powering and Configuring Spartan-3 Generation FPGAs in Compliant PCI Applications and XAPP659, Virtex®-II Pro / Virtex-II Pro X 3.3V I/O Design Guidelines.
3. All Dedicated pins (M0 M2, CCLK, PROG_B, DONE, HSWAP_EN, TCK, TDI, TDO, and TMS) draw power from the V_{CCAUX} rail (2.5V). Meeting the V_{IN} max limit ensures that the internal diode junctions that exist between each of these pins and the V_{CCAUX} rail do not turn on. Table 32 specifies the V_{CCAUX} range used to determine the max limit. When V_{CCAUX} is at its maximum recommended operating level (2.625V), V_{IN} max < 3.125V. As long as the V_{IN} max specification is met, oxide stress is not possible. For information concerning the use of 3.3V signals, see the 3.3V-Tolerant Configuration Interface, page 47. See also XAPP459.
4. For soldering guidelines, see UG112, Device Packaging and Thermal Characteristics and XAPP427, Implementation and Solder Reflow Guidelines for Pb-Free Packages.

Table 29: Supply Voltage Thresholds for Power-On Reset

Symbol	Description	Min	Max	Units
V_{CCINTT}	Threshold for the V_{CCINT} supply	0.4	1.0	V
V_{CCAUXT}	Threshold for the V_{CCAUX} supply	0.8	2.0	V
V_{CCO4T}	Threshold for the V_{CCO} Bank 4 supply	0.4	1.0	V

Notes:

1. V_{CCINT}, V_{CCAUX}, and V_{CCO} supplies may be applied in any order. When applying V_{CCINT} power before V_{CCAUX} power, the FPGA may draw a surplus current in addition to the quiescent current levels specified in Table 34. Applying V_{CCAUX} eliminates the surplus current. The FPGA does not use any of the surplus current for the power-on process. For this power sequence, make sure that regulators with foldback features will not shut down inadvertently.
2. To ensure successful power-on, V_{CCINT}, V_{CCO} Bank 4, and V_{CCAUX} supplies must rise through their respective threshold-voltage ranges with no dips at any point.
3. If a brown-out condition occurs where V_{CCAUX} or V_{CCINT} drops below the retention voltage indicated in Table 31, then V_{CCAUX} or V_{CCINT} must drop below the minimum power-on reset voltage in order to clear out the device configuration content.

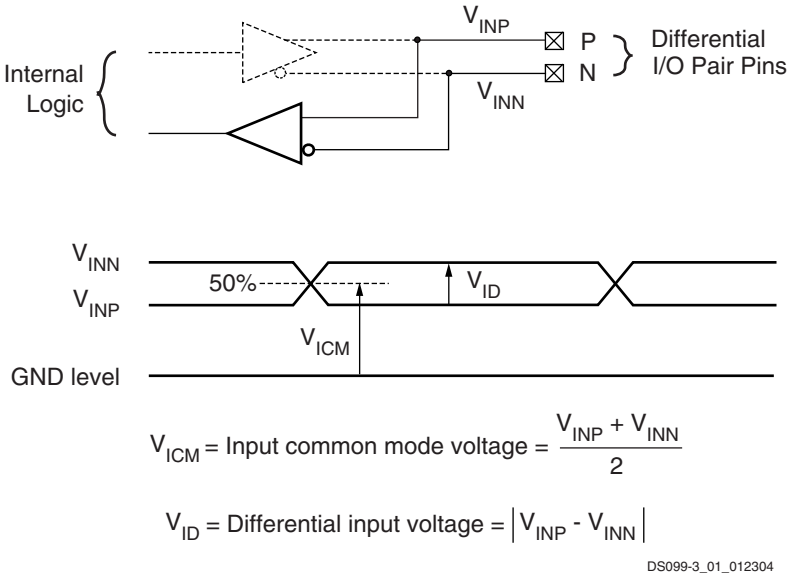

Figure 32: Differential Input Voltages

Table 37: Recommended Operating Conditions for User I/Os Using Differential Signal Standards

Signal Standard (IOSTANDARD)	V_{CCO}[1]			V_{ID}[3]			V_{ICM}		
	Min (V)	Nom (V)	Max (V)	Min (mV)	Nom (mV)	Max (mV)	Min (V)	Nom (V)	Max (V)
LDT_25 (ULVDS_25)	2.375	2.50	2.625	200	600	1000	0.44	0.60	0.78
LVDS_25, LVDS_25_DCI	2.375	2.50	2.625	100	350	600	0.30	1.25	2.20
BLVDS_25	2.375	2.50	2.625	-	350	-	-	1.25	-
LVDSEXT_25, LVDSEXT_25_DCI	2.375	2.50	2.625	100	540	1000	0.30	1.20	2.20
LVPECL_25	2.375	2.50	2.625	100	-	-	0.30	1.20	2.00
RSDS_25	2.375	2.50	2.625	100	200	-	-	1.20	-
DIFF_HSTL_II_18, DIFF_HSTL_II_18_DCI	1.70	1.80	1.90	200	-	-	0.80	-	1.00
DIFF_SSTL2_II, DIFF_SSTL2_II_DCI	2.375	2.50	2.625	300	-	-	1.05	-	1.45

Notes:

1. V_{CCO} only supplies differential output drivers, not input circuits.
2. V_{REF} inputs are not used for any of the differential I/O standards.
3. V_{ID} is a differential measurement.

Table 43: Propagation Times for the IOB Input Path

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max	Max	
Propagation Times						
T_{IOPLI}	The time it takes for data to travel from the Input pin through the IFF latch to the I output with no input delay programmed	LVCMOS25(2), IOBDELAY = NONE	XC3S50	2.01	2.31	ns
			XC3S200	1.50	1.72	ns
			XC3S400	1.50	1.72	ns
			XC3S1000	2.01	2.31	ns
			XC3S1500	2.01	2.31	ns
			XC3S2000	2.01	2.31	ns
			XC3S4000	2.09	2.41	ns
			XC3S5000	2.18	2.51	ns
T_{IOPLID}	The time it takes for data to travel from the Input pin through the IFF latch to the I output with the input delay programmed	LVCMOS25(2), IOBDELAY = IFD	XC3S50	4.75	5.46	ns
			XC3S200	4.89	5.62	ns
			XC3S400	4.76	5.48	ns
			XC3S1000	5.38	6.18	ns
			XC3S1500	5.76	6.62	ns
			XC3S2000	7.04	8.09	ns
			XC3S4000	7.52	8.65	ns
			XC3S5000	7.69	8.84	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 48 and are based on the operating conditions set forth in Table 32 and Table 35.
2. This propagation time requires adjustment whenever a signal standard other than LVCMOS25 is assigned to the data Input. When this is true, add the appropriate Input adjustment from Table 44.

Table 44: Input Timing Adjustments for IOB

Convert Input Time fr om LVCMOS25 to the Following Signal Standard (IOSTANDARD)	Add the Adjustment Below		Units
	Speed Grade		
	-5	-4	
Single-Ended Standards			
GTL, GTL_DCI	0.44	0.50	ns
GTLP, GTLP_DCI	0.36	0.42	ns
HSLVDCI_15	0.51	0.59	ns
HSLVDCI_18	0.29	0.33	ns
HSLVDCI_25	0.51	0.59	ns
HSLVDCI_33	0.51	0.59	ns
HSTL_I, HSTL_I_DCI	0.51	0.59	ns
HSTL_III, HSTL_III_DCI	0.37	0.42	ns
HSTL_I_18, HSTL_I_DCI_18	0.36	0.41	ns
HSTL_II_18, HSTL_II_DCI_18	0.39	0.45	ns
HSTL_III_18, HSTL_III_DCI_18	0.45	0.52	ns
LVCMOS12	0.63	0.72	ns

Table 46: Timing for the IOB Three-State Path

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max(3)	Max(3)	
Synchronous Output Enable/Disable Times						
T_{IOCKHZ}	Time from the active transition at the OTCLK input of the Three-state Flip-Flop (TFF) to when the Output pin enters the high-impedance state	LVCMOS25, 12 mA output drive, Fast slew rate	All	0.74	0.85	ns
T_{IOCKON}(2)	Time from the active transition at TFF s OTCLK input to when the Output pin drives valid data		All	0.72	0.82	ns
Asynchronous Output Enable/Disable Times						
T_{GTS}	Time from asserting the Global Three State (GTS) net to when the Output pin enters the high-impedance state	LVCMOS25, 12 mA output drive, Fast slew rate	XC3S200 XC3S400	7.71	8.87	ns
			XC3S50 XC3S1000 XC3S1500 XC3S2000 XC3S4000 XC3S5000	8.38	9.63	ns
Set/Reset Times						
T_{IOSRHZ}	Time from asserting TFF s SR input to when the Output pin enters a high-impedance state	LVCMOS25, 12 mA output drive, Fast slew rate	All	1.55	1.78	ns
T_{IOSRON}(2)	Time from asserting TFF s SR input at TFF to when the Output pin drives valid data		XC3S200 XC3S400	2.24	2.57	ns
			XC3S50 XC3S1000 XC3S1500 XC3S2000 XC3S4000 XC3S5000	2.91	3.34	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 48 and are based on the operating conditions set forth in Table 32 and Table 35.
2. This time requires adjustment whenever a signal standard other than LVCMOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. When this is true, add the appropriate Output adjustment from Table 47.
3. For minimums, use the values reported by the Xilinx timing analyzer.

Table 47: Output Timing Adjustments for IOB

Convert Output Time from LVCMOS25 with 12mA Drive and Fast Slew Rate to the Following Signal Standard (IOSTANDARD)	Add the Adjustment Below		Units
	Speed Grade		
	-5	-4	
Single-Ended Standards			
GTL	0	0.02	ns
GTL_DCI	0.13	0.15	ns
GTLP	0.03	0.04	ns
GTLP_DCI	0.23	0.27	ns
HSLVDCI_15	1.51	1.74	ns
HSLVDCI_18	0.81	0.94	ns

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Right Half of Package
(Top View)

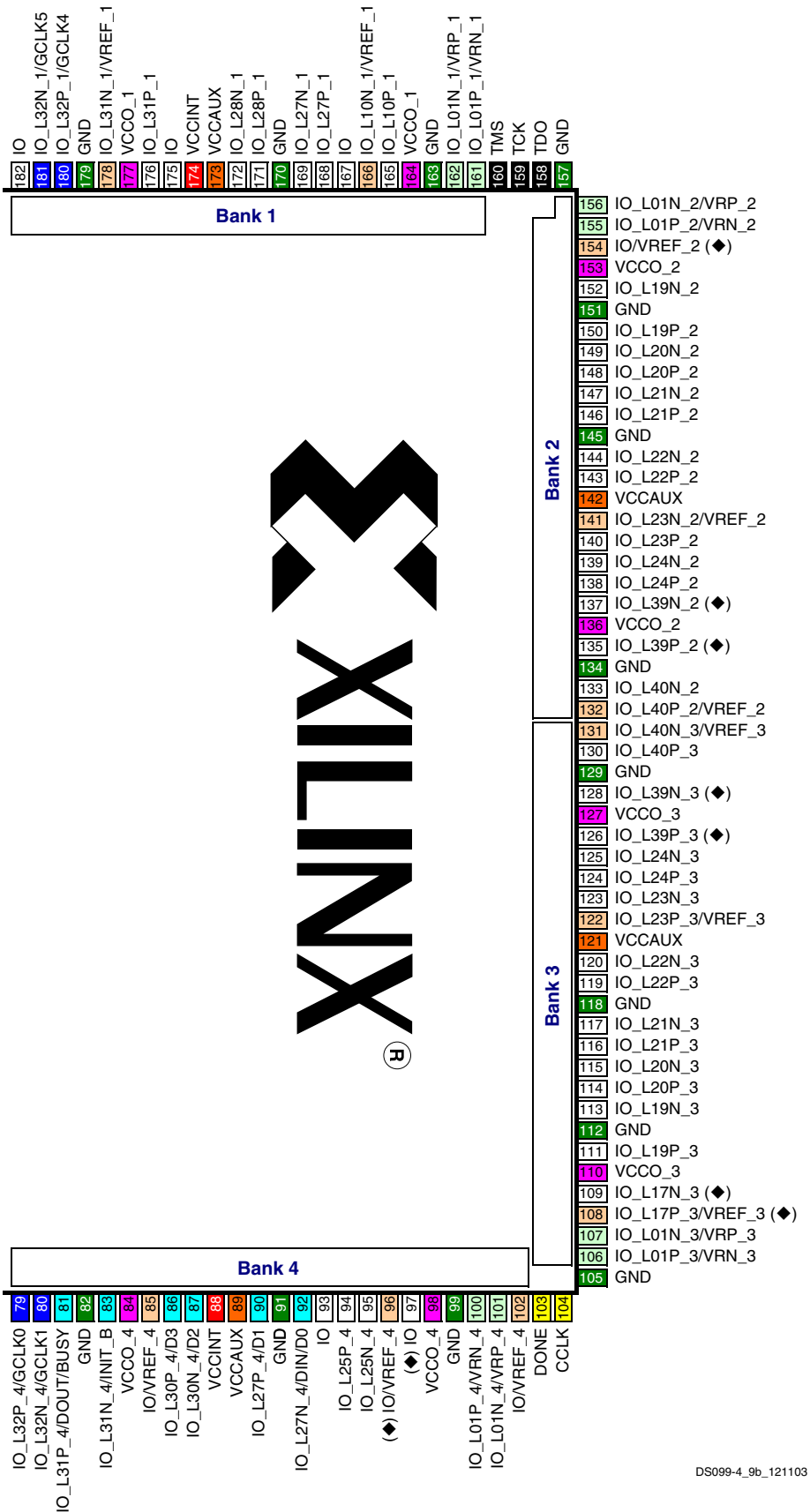

Figure 48: PQ208 Package Footprint (Top View) Continued

Table 100: FG456 Package Pinout (Cont'd)

Bank	3S400 Pin Name	3S1000, 3S1500, 3S2000 Pin Name	FG456 Pin Number	Type
2	IO_L21P_2	IO_L21P_2	E22	I/O
2	IO_L22N_2	IO_L22N_2	G17	I/O
2	IO_L22P_2	IO_L22P_2	G18	I/O
2	IO_L23N_2/VREF_2	IO_L23N_2/VREF_2	F19	VREF
2	IO_L23P_2	IO_L23P_2	G19	I/O
2	IO_L24N_2	IO_L24N_2	F20	I/O
2	IO_L24P_2	IO_L24P_2	F21	I/O
2	N.C. (◆)	IO_L26N_2	G20	I/O
2	N.C. (◆)	IO_L26P_2	H19	I/O
2	IO_L27N_2	IO_L27N_2	G21	I/O
2	IO_L27P_2	IO_L27P_2	G22	I/O
2	N.C. (◆)	IO_L28N_2	H18	I/O
2	N.C. (◆)	IO_L28P_2	J17	I/O
2	N.C. (◆)	IO_L29N_2	H21	I/O
2	N.C. (◆)	IO_L29P_2	H22	I/O
2	N.C. (◆)	IO_L31N_2	J18	I/O
2	N.C. (◆)	IO_L31P_2	J19	I/O
2	N.C. (◆)	IO_L32N_2	J21	I/O
2	N.C. (◆)	IO_L32P_2	J22	I/O
2	N.C. (◆)	IO_L33N_2	K17	I/O
2	N.C. (◆)	IO_L33P_2	K18	I/O
2	IO_L34N_2/VREF_2	IO_L34N_2/VREF_2	K19	VREF
2	IO_L34P_2	IO_L34P_2	K20	I/O
2	IO_L35N_2	IO_L35N_2	K21	I/O
2	IO_L35P_2	IO_L35P_2	K22	I/O
2	IO_L38N_2	IO_L38N_2	L17	I/O
2	IO_L38P_2	IO_L38P_2	L18	I/O
2	IO_L39N_2	IO_L39N_2	L19	I/O
2	IO_L39P_2	IO_L39P_2	L20	I/O
2	IO_L40N_2	IO_L40N_2	L21	I/O
2	IO_L40P_2/VREF_2	IO_L40P_2/VREF_2	L22	VREF
2	VCCO_2	VCCO_2	H17	VCCO
2	VCCO_2	VCCO_2	H20	VCCO
2	VCCO_2	VCCO_2	J16	VCCO
2	VCCO_2	VCCO_2	K16	VCCO
2	VCCO_2	VCCO_2	L16	VCCO
3	IO	IO	Y21	I/O
3	IO_L01N_3/VRP_3	IO_L01N_3/VRP_3	Y20	DCI
3	IO_L01P_3/VRN_3	IO_L01P_3/VRN_3	Y19	DCI
3	IO_L16N_3	IO_L16N_3	W22	I/O

Table 100: FG456 Package Pinout (Cont'd)

Bank	3S400 Pin Name	3S1000, 3S1500, 3S2000 Pin Name	FG456 Pin Number	Type
6	N.C. (◆)	IO_L28N_6	R5	I/O
6	N.C. (◆)	IO_L28P_6	P6	I/O
6	N.C. (◆)	IO_L29N_6	R2	I/O
6	N.C. (◆)	IO_L29P_6	R1	I/O
6	N.C. (◆)	IO_L31N_6	P5	I/O
6	N.C. (◆)	IO_L31P_6	P4	I/O
6	N.C. (◆)	IO_L32N_6	P2	I/O
6	N.C. (◆)	IO_L32P_6	P1	I/O
6	N.C. (◆)	IO_L33N_6	N6	I/O
6	N.C. (◆)	IO_L33P_6	N5	I/O
6	IO_L34N_6/VREF_6	IO_L34N_6/VREF_6	N4	VREF
6	IO_L34P_6	IO_L34P_6	N3	I/O
6	IO_L35N_6	IO_L35N_6	N2	I/O
6	IO_L35P_6	IO_L35P_6	N1	I/O
6	IO_L38N_6	IO_L38N_6	M6	I/O
6	IO_L38P_6	IO_L38P_6	M5	I/O
6	IO_L39N_6	IO_L39N_6	M4	I/O
6	IO_L39P_6	IO_L39P_6	M3	I/O
6	IO_L40N_6	IO_L40N_6	M2	I/O
6	IO_L40P_6/VREF_6	IO_L40P_6/VREF_6	M1	VREF
6	VCCO_6	VCCO_6	M7	VCCO
6	VCCO_6	VCCO_6	N7	VCCO
6	VCCO_6	VCCO_6	P7	VCCO
6	VCCO_6	VCCO_6	R3	VCCO
6	VCCO_6	VCCO_6	R6	VCCO
7	IO	IO	C2	I/O
7	IO_L01N_7/VRP_7	IO_L01N_7/VRP_7	C3	DCI
7	IO_L01P_7/VRN_7	IO_L01P_7/VRN_7	C4	DCI
7	IO_L16N_7	IO_L16N_7	D1	I/O
7	IO_L16P_7/VREF_7	IO_L16P_7/VREF_7	C1	VREF
7	IO_L17N_7	IO_L17N_7	E4	I/O
7	IO_L17P_7	IO_L17P_7	D4	I/O
7	IO_L19N_7/VREF_7	IO_L19N_7/VREF_7	D3	VREF
7	IO_L19P_7	IO_L19P_7	D2	I/O
7	IO_L20N_7	IO_L20N_7	F4	I/O
7	IO_L20P_7	IO_L20P_7	E3	I/O
7	IO_L21N_7	IO_L21N_7	E1	I/O
7	IO_L21P_7	IO_L21P_7	E2	I/O
7	IO_L22N_7	IO_L22N_7	G6	I/O
7	IO_L22P_7	IO_L22P_7	F5	I/O

FT256 Footprint

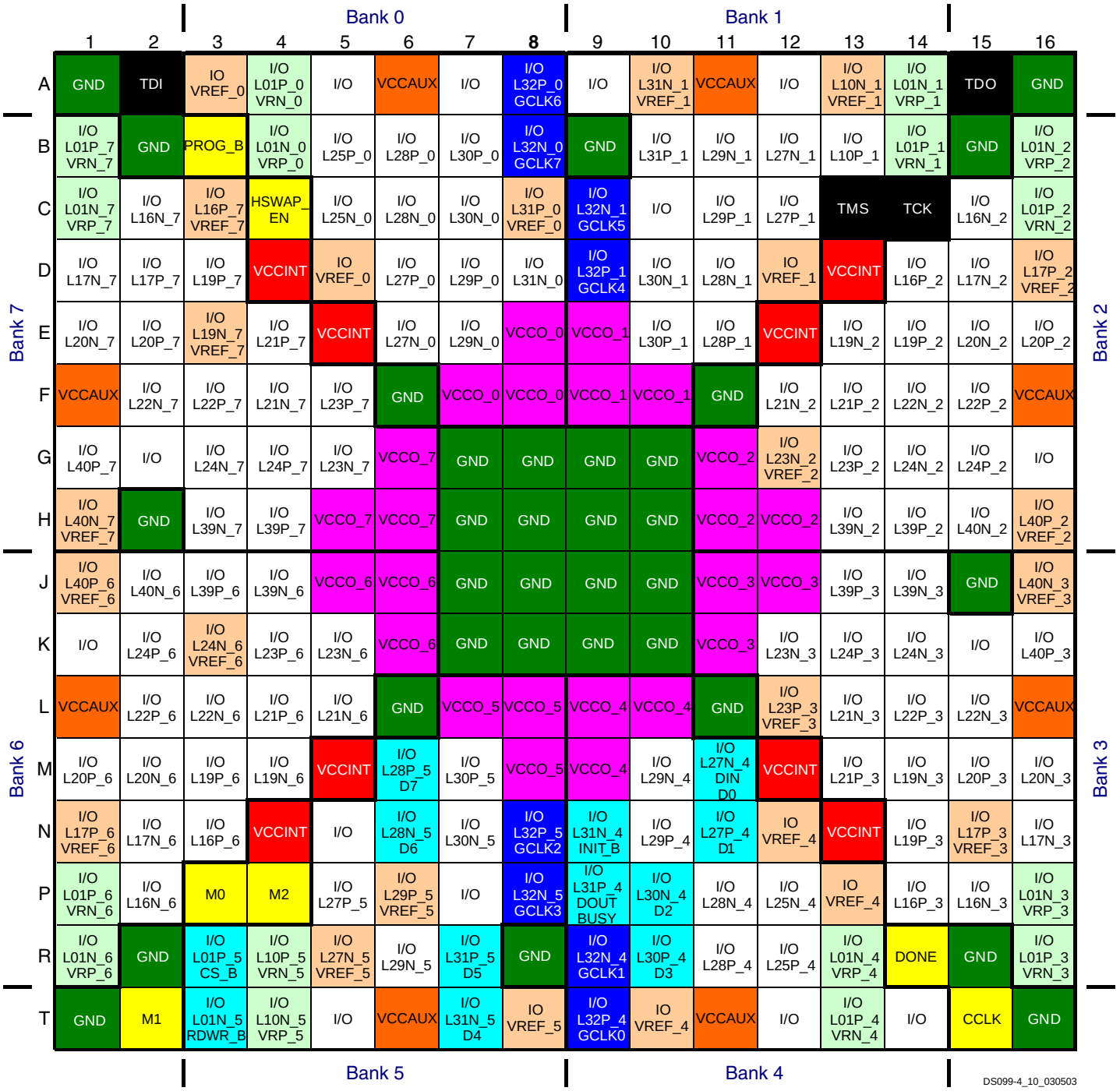

Figure 49: **FT256 Package Footprint (Top View)**

113	**I/O:** Unrestricted, general-purpose user I/O	12	**DUAL:** Configuration pin, then possible user I/O	24	**VREF:** User I/O or input voltage reference for bank
16	**DCI:** User I/O or reference resistor input for bank	8	**GCLK:** User I/O or global clock buffer input	24	**VCCO:** Output voltage supply for bank
7	**CONFIG:** Dedicated configuration pins	4	**JTAG:** Dedicated JTAG port pins	8	**VCCINT:** Internal core voltage supply (+1.2V)
0	**N.C.:** No unconnected pins in this package	32	**GND:** Ground	8	**VCCAUX:** Auxiliary voltage supply (+2.5V)